

August 2012

# **FDP040N06**

# N-Channel PowerTrench<sup>®</sup> MOSFET 60V, 168A, $4.0m\Omega$

#### **Features**

- $R_{DS(on)} = 3.2 m\Omega$  ( Typ.) @  $V_{GS} = 10 V$ ,  $I_D = 75 A$
- · Fast Switching Speed
- · Low Gate Charge
- $\bullet$  High Performance Trench Technology for Extremely Low  $R_{\mbox{\scriptsize DS(on)}}$
- · High Power and Current Handling Capability
- · RoHS Compliant

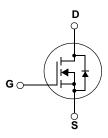
# **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

# **Application**

• DC to DC convertors / Synchronous Rectification





# MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol		Parameter		FDP040N06	Units
V <sub>DSS</sub>	Drain to Source Voltage			60	V
V <sub>GSS</sub>	Gate to Source Voltage	sate to Source Voltage			V
		-Continuous (T <sub>C</sub> = 25°C, Silicion	Limited)	168*	
I <sub>D</sub>	Drain Current	-Continuous (T <sub>C</sub> = 100°C, Silicior	n Limited)	118*	Α
		-Continuous (T <sub>C</sub> = 25°C, Package	e Limited)	120	
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	672	Α
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		(Note 2)	872	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		(Note 3)	7.0	V/ns
D	Danier Diagination	$(T_C = 25^{\circ}C)$		231	W
$P_{D}$	Power Dissipation	- Derate above 25°C		1.54	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Te	Operating and Storage Temperature Range			°C
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

<sup>\*</sup>Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 120A.

#### **Thermal Characteristics**

Symbol	Parameter	FDP040N06	Units	
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max	0.65	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max 62.5		C/VV	

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP040N06	FDP040N06	TO-220	Tube	-	50

# **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250\mu A, V_{GS} = 0V, T_C = 25^{\circ}C$	60	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$ , Referenced to $25^{\circ}\text{C}$	-	0.04	-	V/°C
	Zoro Coto Voltago Proin Current	$V_{DS} = 60V, V_{GS} = 0V$	-	-	1	
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 60V, V_{GS} = 0V, T_{C} = 150^{\circ}C$	-	-	500	μΑ
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

### **On Characteristics**

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.5	3.5	4.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 75A$	-	3.2	4.0	mΩ
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10V, I_{D} = 75A$	-	169	-	S

# **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 05V V 0V	-	6190	8235	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz		900	1195	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			385	580	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V	V <sub>DS</sub> = 48V, I <sub>D</sub> = 75A	-	102	133	nC
$Q_{gs}$	Gate to Source Gate Charge	V <sub>GS</sub> = 10V	-	32	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	(Note 4)	-	32	-	nC

# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	30	70	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 30V, I_{D} = 75A$	-	40	90	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10V$ , $R_{GEN} = 4.7\Omega$	-	55	120	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)	-	24	58	ns

#### **Drain-Source Diode Characteristics**

Is	Maximum Continuous Drain to Source Diode Forward Current			=	168	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current			-	672	Α
$V_{SD}$	Drain to Source Diode Forward Voltage $V_{GS} = 0V$ , $I_{SD} = 75A$		-	=	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 75A	-	41	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge $dI_F/dt = 100A/\mu s$		-	47	-	nC

- **Notes:**1. Repetitive Rating: Pulse width limited by maximum junction temperature 2: L = 0.31mH,  $I_{AS} = 75A$ ,  $V_{DD} = 50V$ ,  $R_G = 25\Omega$ , Starting  $T_J = 25^{\circ}C$ 3:  $I_{SD} \le 75A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$ 4: Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

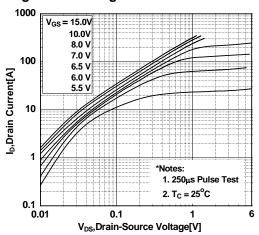


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

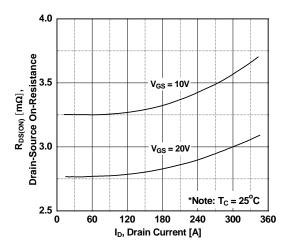


Figure 5. Capacitance Characteristics

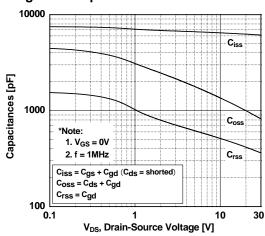


Figure 2. Transfer Characteristics

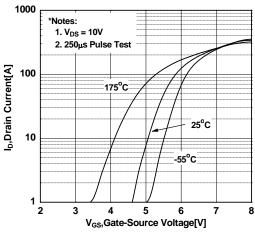


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

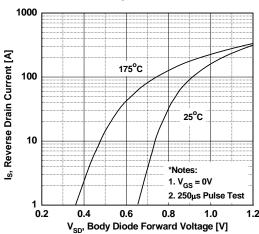
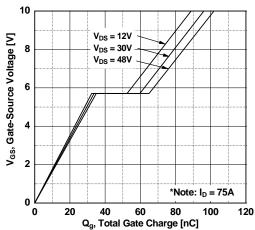


Figure 6. Gate Charge Characteristics



# **Typical Performance Characteristics (Continued)**

Figure 7. Breakdown Voltage Variation vs. Temperature

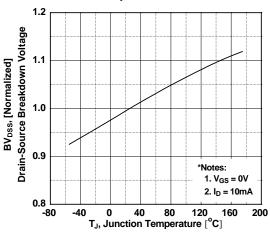


Figure 9. Maximum Safe Operating Area

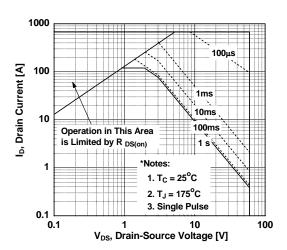


Figure 8. On-Resistance Variation vs. Temperature

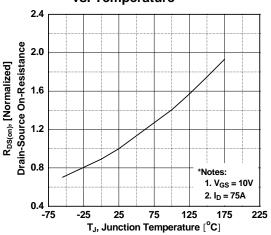


Figure 10. Maximum Drain Current vs. Case Temperature

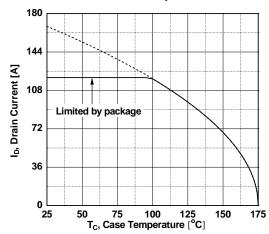
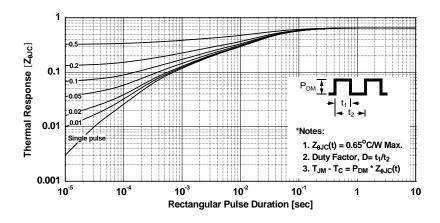
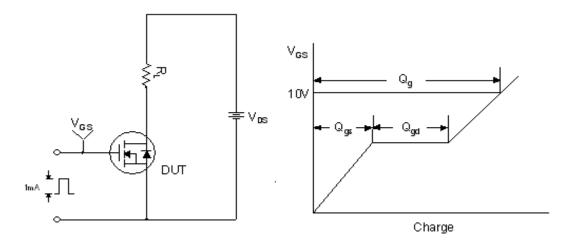


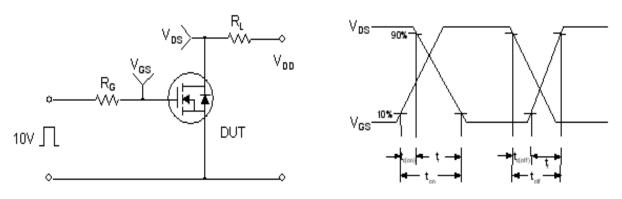
Figure 11. Transient Thermal Response Curve



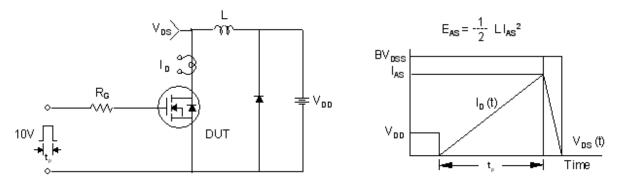
## **Gate Charge Test Circuit & Waveform**



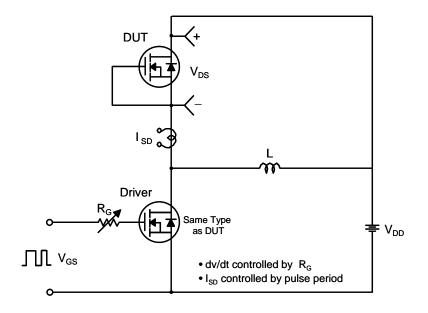
### **Resistive Switching Test Circuit & Waveforms**

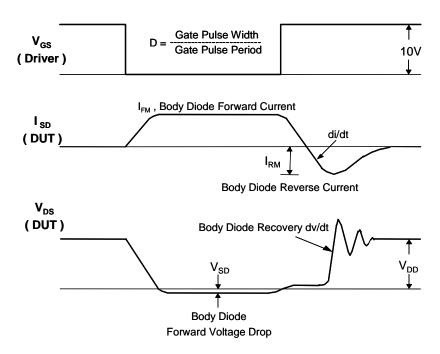


**Unclamped Inductive Switching Test Circuit & Waveforms** 



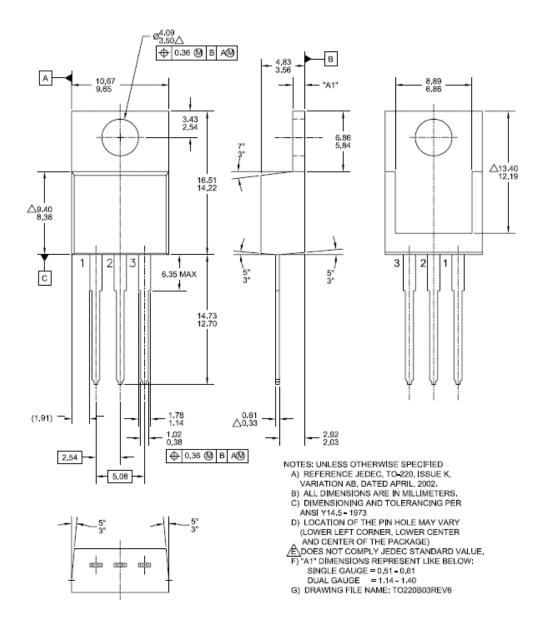
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms





### **Mechanical Dimensions**

# **TO-220AB**



Dimensions in Millimeters





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